STW65N80K5



N-channel 800 V, 0.07 Ω typ., 46 A MDmesh™ K5 Power MOSFET in a TO-247 package

Datasheet - production data

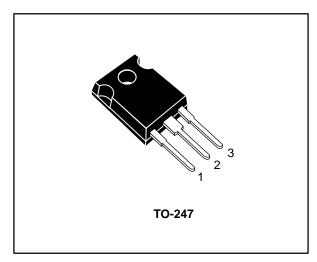
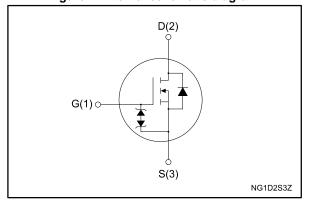


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD	Ртот
STW65N80K5	800 V	0.08 Ω	46 A	446 W

- Industry's lowest R_{DS(on)} x area
- Industry's best figure of merit (FoM)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STW65N80K5	65N80K5	TO-247	Tube

Contents STW65N80K5

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STW65N80K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	±30	V
1-	Drain current (continuous) at T _{case} = 25 °C	46	Λ
I _D	Drain current (continuous) at T _{case} = 100 °C	30	A
I _{DM} ⁽¹⁾	Drain current (pulsed)	184	Α
P _{TOT}	Total dissipation at T _{case} = 25 °C	446	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	4.5	\//n a
dv/dt ⁽³⁾	dv/dt ⁽³⁾ MOSFET dv/dt ruggedness		V/ns
T _{stg}	Storage temperature	FF to 150	°C
Tj	Operating junction temperature	-55 to 150	°C

Notes:

Table 3: Thermal data

Symbol Parameter		Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.28	9004
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit	
I _{AR} ⁽¹⁾	I _{AR} ⁽¹⁾ Avalanche current, repetitive or not repetitive			
E _{AS} ⁽²⁾	E _{AS} ⁽²⁾ Single pulse avalanche energy			

Notes:

⁽¹⁾ Pulse width is limited by safe operating area.

 $^{^{(2)}}$ $I_{SD} \leq$ 46 A, di/dt=100 A/µs; V_{DS} peak < $V_{(BR)DSS},$ V_{DD} = 80% $V_{(BR)DSS}.$

 $^{^{(3)}}$ V_{DS} ≤ 640 V

 $^{^{\}left(1\right)}$ Pulse width limited by $T_{jmax}.$

 $^{^{(2)}}$ starting T_j = 25 °C, I_D = $I_{AR},\,V_{DD}$ = 50 V.

Electrical characteristics STW65N80K5

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	800			V
	Zaro goto voltogo droin	$V_{GS} = 0 \text{ V}, V_{DS} = 800 \text{ V}$			1	
IDSS	I _{DSS} Zero gate voltage drain current	V _{GS} = 0 V, V _{DS} = 800 V, T _{case} = 125 °C			50	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 23 A		0.07	0.08	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		1	3230	1	
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	310	-	pF
Crss	Reverse transfer capacitance	Ves = 0 V	-	3	-	ρ.
Coss(eq) ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0$ to 640 V, $V_{GS} = 0$ V	1	734	1	pF
R _G	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	1.9	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, I_D = 46 \text{ A},$	ı	92	ı	
Qgs	Gate-source charge	V _{GS} = 10 V (see <i>Figure 14:</i> "Test circuit for gate charge	-	18	-	nC
Q _{gd}	Gate-drain charge	behavior")	1	65	-	

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 400 V, I _D = 23 A	-	34	-	
tr	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 13: "Test circuit for	ı	30	ı	
t _{d(off)}	Turn-off delay time	resistive load switching times"	ı	90	ı	ns
t _f	Fall time	and Figure 18: "Switching time waveform")	-	10	-	

 $^{^{(1)}}$ C_{oss(eq)} is defined as a constant equivalent capacitance giving the same charging time as Coss when V_{DS} increases from 0 to 80% V_{DSS}.

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		46	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		184	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 46 A	-		1.5	V
t _{rr}	Reverse recovery time	$I_{SD} = 46 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	650		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 15: "Test circuit for inductive load switching and diode recovery times")	-	20		μC
I _{RRM}	Reverse recovery current		-	60		Α
t _{rr}	Reverse recovery time	$I_{SD} = 46 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	845		ns
Qrr	Reverse recovery charge	V_{DD} = 60 V, T_j = 150 °C (see Figure 15: "Test circuit for	-	28		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	66		Α

Notes:

Table 9: Gate-source Zener diode

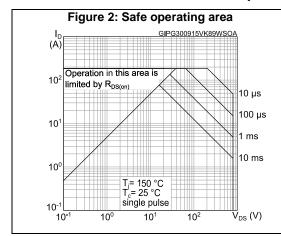
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

⁽¹⁾ Pulse width is limited by safe operating area.

 $^{^{(2)}}$ Pulse test: pulse duration = 300 μ s, duty cycle 1.5%.

2.1 Electrical characteristics (curves)



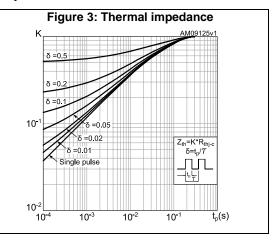
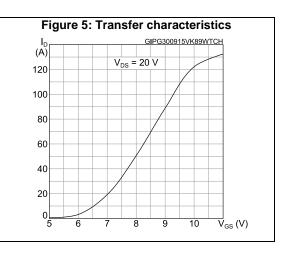
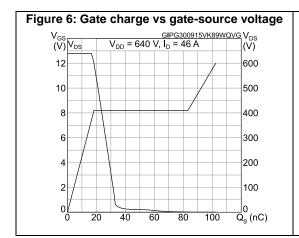
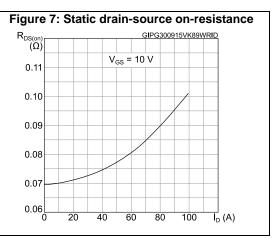


Figure 4: Output characteristics GIPG300915VK89WOCH I_D (A) 120 V_{GS} = 10 V 100 80 V_{GS} = 9 V 60 V_{GS} = 8 V 40 $V_{GS} = 7 V$ 20 V_{GS} = 6 V 12 16 V_{DS} (V)







STW65N80K5 Electrical characteristics

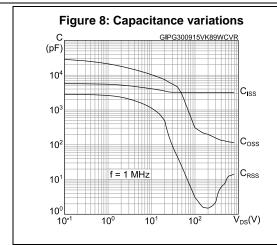


Figure 9: Normalized gate threshold voltage vs temperature

V_{GS(th)}

(norm.)

1.2

1.0

0.8

0.6

0.4

0.2

-75

-25

25

75

125

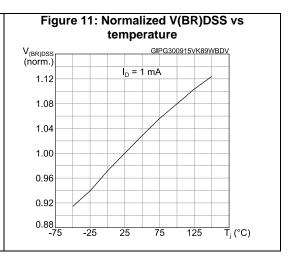
T_j (°C)

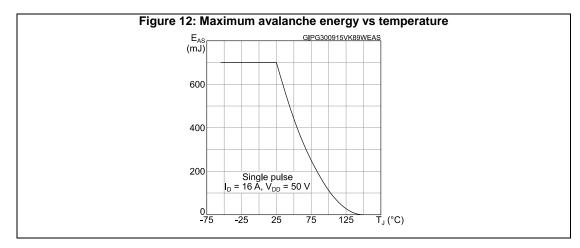
Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG300915VK89WRON (norm.)

2.6 V_{GS} = 10 V

2.2 1.8 1.4 1.0 0.6 0.2 -75 -25 25 75 125 T_j (°C)





Test circuits STW65N80K5

3 Test circuits

Figure 13: Test circuit for resistive load switching times

Figure 14: Test circuit for gate charge behavior

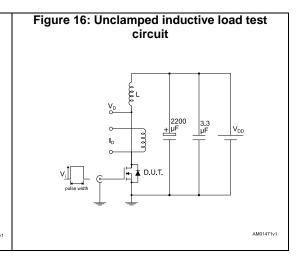
12 V 47 kΩ 100 nF D.U.T.

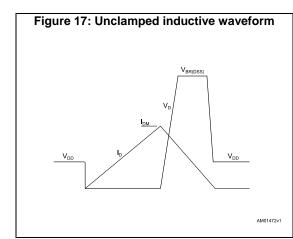
Vas pulse width 1 kΩ

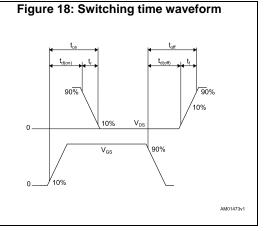
Vas pulse width 1 kΩ

AM01468v1

Figure 15: Test circuit for inductive load switching and diode recovery times







4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

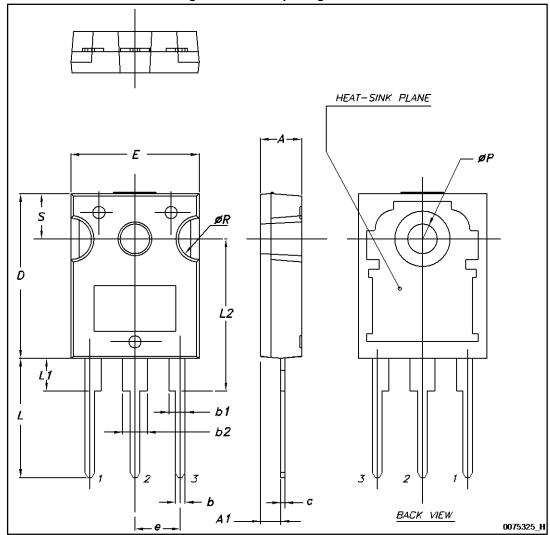


Figure 19: TO-247 package outline

Table 10: TO-247 package mechanical data

Dim		mm.	
Dim.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

STW65N80K5 Revision history

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
21-May-2015	1	First release.
02-Oct-2015	2	Text and formatting changes throughout document. Datasheet status promoted from preliminary to production data. On cover page: - updated title description and Features table. Updated sections - Electrical ratings and Electrical characteristics. Added section - Electrical characteristics (curves).

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